IGBT - Field Stop, Trench 650 V, 75 A

FGH75T65SQDT

Description

Using novel field stop IGBT technology, ON Semiconductor's new series of field stop 4th generation IGBTs offer the optimum performance for solar inverter, UPS, welder, telecom, ESS and PFC applications where low conduction and switching losses are essential.

Features

- Max Junction Temperature $T_J = 175^{\circ}C$
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: $V_{CE(sat)} = 1.6 \text{ V} (Typ.) @ I_C = 75 \text{ A}$
- 100% of the Parts Tested for I_{LM}
- High Input Impedance
- Fast Switching
- Tighten Parameter Distribution
- This Device is Pb-Free and is RoHS Compliant

Applications

• Solar Inverter, UPS, Welder, Telecom, ESS, PFC

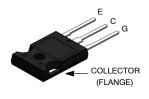


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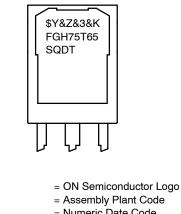
V _{CES}	ι _c
650 V	75 A





TO-247-3LD CASE 340CH

MARKING DIAGRAM



· ·	5
&Z	= Assembly Plant Code
&3	= Numeric Date Code
&K	= Lot Code
FGH75T65SQDT	= Specific Device Code

\$Y

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

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ABSOLUTE MAXIMUM RATINGS

Symbol	Description		FGH50T65SQD-F155	Unit
V _{CES}	Collector to Emitter Voltage		650	V
V _{GES}	Gate to Emitter Voltage		±20	V
	Transient Gate to Emitter Voltage		±30	V
Ι _C	Collector Current T	_C = 25°C	150	А
	Т	_C = 100°C	75	А
I _{LM} (Note 1)	Pulsed Collector Current T	_ _C = 25°C	300	А
I _{CM} (Note 2)	Pulsed Collector Current	llector Current		А
١ _F	Diode Forward Current T	$T_{C} = 25^{\circ}C$		А
	Diode Forward Current T	_C = 100°C	75	А
I _{FM}	Pulsed Diode Maximum Forward Current		300	А
PD	Maximum Power Dissipation T	− _C = 25°C	375	W
	Т	_C = 100°C	188	W
TJ	Operating Junction Temperature		–55 to +175	°C
T _{STG}	Storage Temperature Range		–55 to +175	°C
ΤL	Maximum Lead Temp. for Soldering Purposes, 1	/8" from Case for 5 Seconds	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
V_{CC} = 400 V, V_{GE} = 15 V, I_C = 300 A, R_G = 21 Ω, Inductive Load.
Repetitive rating: Pulse width limited by max. junction temperature.

THERMAL CHARACTERISTICS

Symbol	Parameter	FGH75T65SQDT-F155	Unit
R _{θJC} (IGBT)	Thermal Resistance, Junction to Case, Max.	0.4	°C/W
$R_{\theta JC}$ (Diode)	Thermal Resistance, Junction to Case, Max.	0.65	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient, Max.	40	°C/W

PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Qty per Tube
FGH75T65SQDT-F155	FGH75T65SQDT	TO-247-3LD	Tube	-	-	30

ELECTRICAL CHARACTERISTICS OF THE IGBT (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHARACT	ERISTICS					
BV _{CES}	Collector to Emitter Breakdown Voltage	V _{GE} = 0 V, I _C = 1 mA	650	-	-	V
$\Delta \text{BV}_{\text{CES}} / \Delta \text{T}_{\text{J}}$	Temperature Coefficient of Breakdown Voltage	I_{C} = 1 mA, Reference to 25°C	-	0.6	-	V/°C
I _{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0 V$	-	-	250	μA
I _{GES}	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0 V$	_	-	±400	nA
ON CHARACTE	RISTICS	·				
V _{GE(th)}	G-E Threshold Voltage	I_{C} = 75 mA, V_{CE} = V_{GE}	2.6	4.5	6.4	V
V _{CE(sat)}	Collector to Emitter Saturation Voltage	I_{C} = 75 A, V_{GE} = 15 V, T_{C} = 25 °C	-	1.6	2.1	V
		I_{C} = 75 A, V _{GE} = 15 V, T _C = 175°C	-	1.92	-	V
DYNAMIC CHAI	RACTERISTICS					-
C _{ies}	Input Capacitance	V _{CE} = 30 V, V _{GE} = 0 V,	-	4845	-	pF
C _{oes}	Output Capacitance	f = 1MHz	-	155	-	pF
C _{res}	Reverse Transfer Capacitance		_	14	-	pF
SWITCHING CH	IARACTERISTICS	•				
T _{d(on)}	Turn–On Delay Time	$V_{CC} = 400 \text{ V}, I_C = 18.8 \text{ A}, R_G = 4.7 \Omega, V_{GE} = 15 \text{ V}, Inductive Load, T_C = 25^{\circ}\text{C}$	_	23	-	ns
Tr	Rise Time		-	10	-	ns
T _{d(off)}	Turn–Off Delay Time		-	120	-	ns
Tf	Fall Time		_	7	-	ns
Eon	Turn–On Switching Loss		-	300	-	μJ
E _{off}	Turn-Off Switching Loss	1	-	70	-	μJ
E _{ts}	Total Switching Loss	1	-	370	-	μJ
T _{d(on)}	Turn–On Delay Time	$V_{CC} = 400 \text{ V}, \text{ I}_{C} = 37,5 \text{ A},$	_	26	_	ns
Tr	Rise Time	$R_G = 4.7 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_C = 25$ °C	-	19	-	ns
T _{d(off)}	Turn–Off Delay Time		-	114	-	ns
T _f	Fall Time	1 1	-	11	-	ns
Eon	Turn–On Switching Loss	1 1	_	746	-	μJ
E _{off}	Turn–Off Switching Loss	1	_	181	-	μJ
E _{ts}	Total Switching Loss] [-	927	-	μJ
T _{d(on)}	Turn–On Delay Time	$V_{CC} = 400 \text{ V}, I_{C} = 18.5 \text{ A},$	_	22	-	ns
T _r	Rise Time	$R_G = 4.7 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_C = 175^{\circ}C$	_	12	-	ns
T _{d(off)}	Turn–Off Delay Time	1 1	-	135	-	ns
Т _f	Fall Time	1 1	-	14	-	ns
Eon	Turn–On Switching Loss	1	-	760	-	μJ
E _{off}	Turn–Off Switching Loss	1 1	-	180	-	μJ
E _{ts}	Total Switching Loss		_	940	-	μJ

ELECTRICAL CHARACTERISTICS OF THE IGBT ($T_C = 25^{\circ}C$ unless otherwise noted) (continued)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit				
SWITCHING C	VITCHING CHARACTERISTICS									
T _{d(on)}	Turn-On Delay Time	V _{CC} = 400 V, I _C = 37.5 A, R _G = 4.7 Ω, V _{GE} = 15 V,	-	24	-	ns				
T _r	Rise Time	Inductive Load, $T_C = 175^{\circ}C$	-	24	-	ns				
T _{d(off)}	Turn-Off Delay Time		-	125	-	ns				
T _f	Fall Time		-	10	-	ns				
Eon	Turn-On Switching Loss		-	1520	I	μJ				
E _{off}	Turn-Off Switching Loss		-	401	-	μJ				
E _{ts}	Total Switching Loss		-	1921	-	μJ				
Qg	Total Gate Charge	V _{CE} = 400 V, I _C = 75 A, V _{GE} = 15 V	-	128	-	nC				
Q _{ge}	Gate to Emitter Charge	v _{GE} = 13 v	-	23	-	nC				
Q _{gc}	Gate to Collector Charge		-	29	-	nC				

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ELECTRICAL CHARACTERISTICS OF THE DIODE (T_C = 25° C unless otherwise noted)

Symbol	Parameter	Test Co	Min	Тур	Max	Unit	
V _{FM}	Diode Forward Voltage	I _F = 75 A	$T_C = 25^{\circ}C$	-	1.8	2.1	V
			T _C = 175°C	-	1.7	-	
E _{rec}	Reverse Recovery Energy	l _F = 75 A, dl _F /dt = 200 A/μs	T _C = 175°C	-	160	-	μJ
T _{rr}	Diode Reverse Recovery Time	αιμ/αι = 200 Α/μο	$T_{C} = 25^{\circ}C$	-	76	-	ns
			T _C = 175°C	-	270	-	
Q _{rr}	Diode Reverse Recovery Charge		$T_{C} = 25^{\circ}C$	-	206	-	nC
			T _C = 175°C	-	2199	-	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

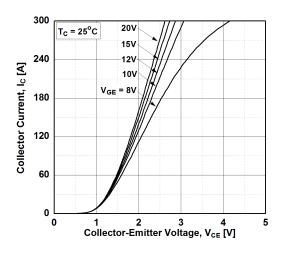


Figure 1. Typical Output Characteristics

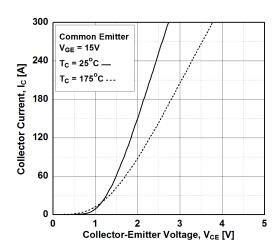


Figure 3. Typical Saturation Voltage Characteristics

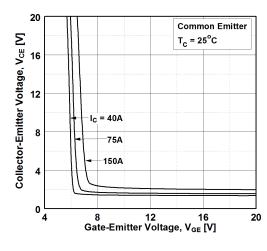


Figure 5. Saturation Voltage vs. V_{GE}

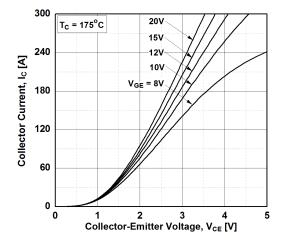


Figure 2. Typical Output Characteristics

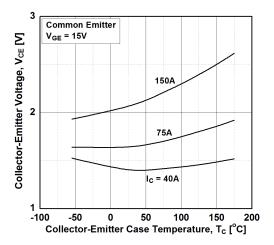


Figure 4. Saturation Voltage vs. Case Temperature at Variant Current Level

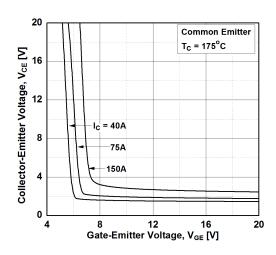


Figure 6. Saturation Voltage vs. V_{GE}

TYPICAL CHARACTERISTICS (Continued)

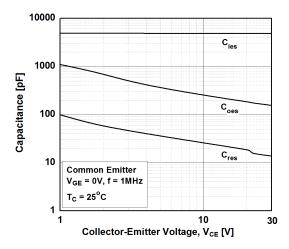


Figure 7. Capacitance Characteristics

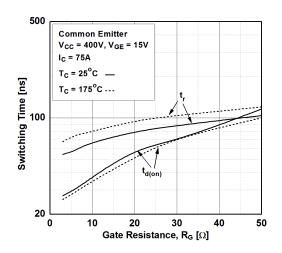


Figure 9. Turn-on Characteristics vs. Gate Resistance

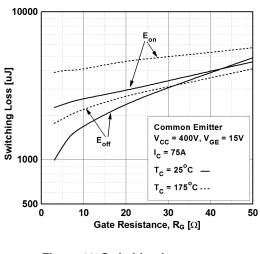


Figure 11. Switching Loss vs. Gate Resistance

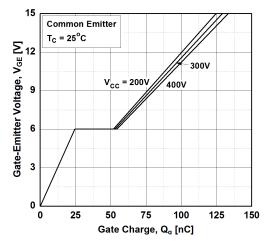


Figure 8. Gate Charge Characteristics

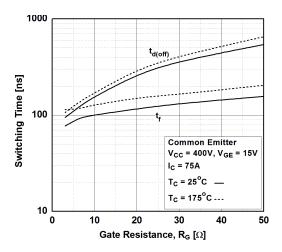
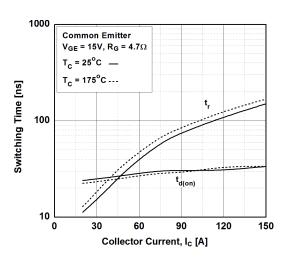
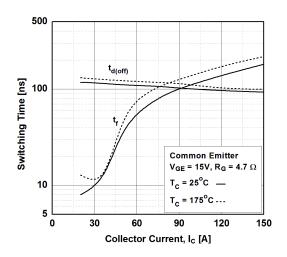


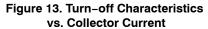
Figure 10. Turn-off Characteristics vs. Gate Resistance





TYPICAL CHARACTERISTICS (Continued)





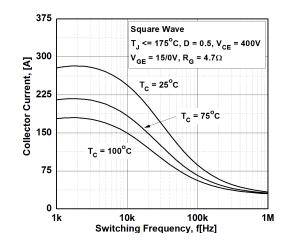


Figure 15. Load Current vs. Frequency

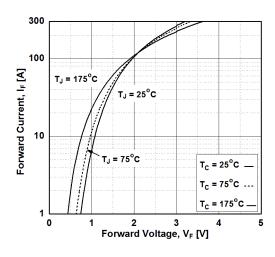


Figure 17. Forward Characteristics

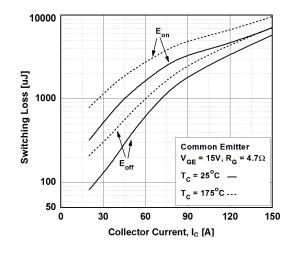


Figure 14. Switching Loss vs. Collector Current

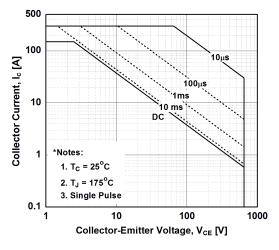


Figure 16. SOA Characteristics

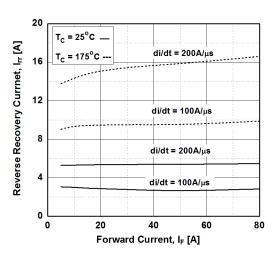


Figure 18. Reverse Recovery Current

TYPICAL CHARACTERISTICS (Continued)

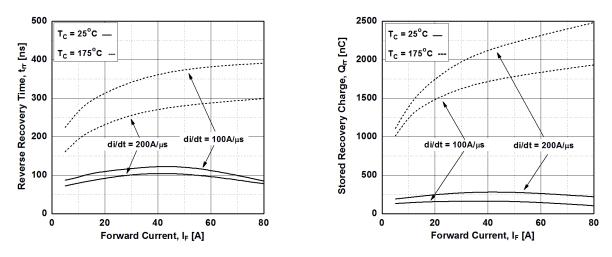


Figure 19. Reverse Recovery Time



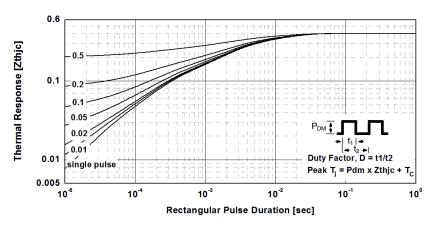


Figure 21. Transient Thermal Impedance of IGBT

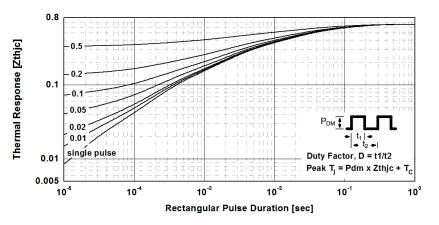
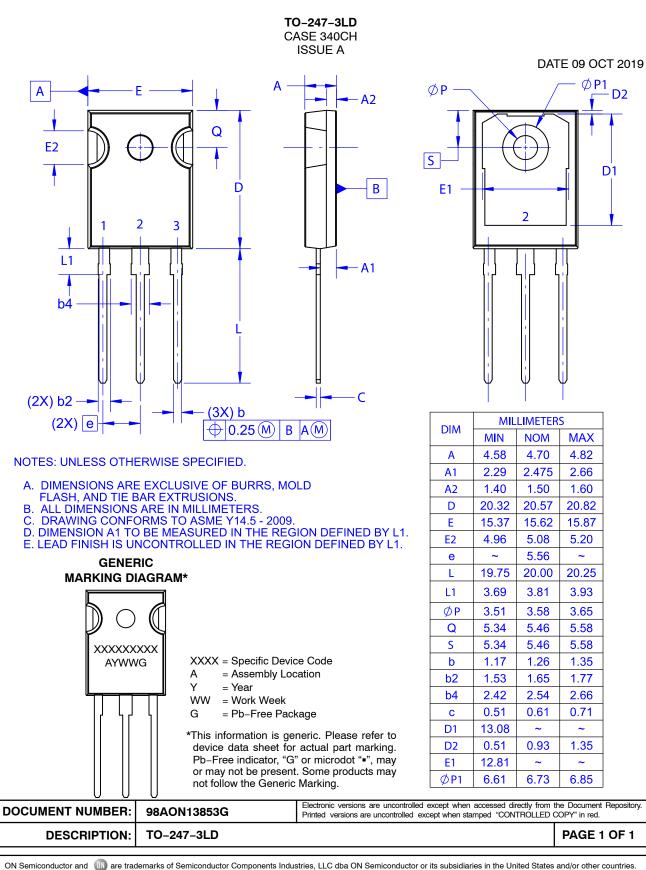


Figure 22. Transient Thermal Impedance of Diode





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